



- A20-0109 **"Analysis and Characterization of Tapered Chambers"**
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Emily Mendoza¹ and Shea Watson² (¹Benefield Anechoic Facility (BAF), ²Air Force Research Laboratory (AFRL))
- A20-0051 **"Geometry- and angle-dependent monostatic scattering of microwave absorbers"**
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Vince Rodriguez (NSI-MI Technologies)
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Vince Rodriguez¹ and Zhong Chen² (¹NSI-MI Technologies, ²ETS-Lindgren)
- A20-0102 **"Mitigation Techniques for the Concealment of a New Fire Suppression Network and HVAC System Within a Pre-Existing Large Anechoic Chamber"**
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